Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/037,590	CHAN ET AL.	
Examiner	Art Unit	
Martin Lerner	2654	

SEARCHED				
Class	Subclass	Date	Examiner	
ALL	UPDATED	8/24/2005	ML	
379	265.03	8/24/2005	ML	
379	265.07	8/24/2005	ML	
379	266.01	8/24/2005	ML	

INTERFERENCE SEARCHED				
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